IMAGE GALLERY

Cornell Announces Results of 2004 Materials Images Competition

The Materials Research Society's Student Chapter at Cornell University, in collaboration with Cornell's Department of Materials Science and Engineering (MSE), announced the results of its third annual Microscopy Image Competition: Images in the Material World. Three awards were given in each of two categories: most scientifically significant image and most artistic image. Prizes of digital cameras were provided by the Eastman Kodak Company. The competition was promoted to undergraduate students in the United States and Canada. Entries were judged by Cornell MS&E professor Christopher Ober. More information on the contest is available at Web site www.mse.cornell.edu.

Most Scientifically Significant Image 1st Place



Carbon Nanotube Lithography Craig S. Terry, University of Washington, Seattle

Imaging: Scanning electron microscope

Description: The top half of the image is an imprint in 100-nm-thick poly(methyl methacrylate) of a multiwalled carbon nanotube on a Si substrate, briefly reactive-ion-etched, and coated with Teflon; the bottom half is the stamp that made the imprint. Note that the nanotube has separated from its base during mold release.



Crater Christina Pina University of Texas at El Paso

Imaging: Optical microscope **Description:** Projectile impact on a piece of stainless steel at 3.4 km/s. The crater was then cut in half, polished, and electronically etched. 3rd Place



The Nanotube Mother **Priscilla A. Guerrero** University of Texas at El Paso

Imaging: Transmission electron microscope

Description: Aggregate of carbon nanotubes collected from an El Paso power plant.



Most Artistic Image

Lead Snowflakes Dale Anderson, Michigan Technological University

Imaging: Single-beam atomic force microscope

Description: The "snowflakes" are the result of lead condensing around impurities on a single-crystal silicon substrate. The growth mechanism is believed to be vapor condensation, and the image is presented in false-color height mode. The width of the image is $60 \,\mu\text{m}$.

2nd Place

3rd Place



Tarantalum Kate Jackson Cornell University

Imaging: Scanning transmission electron microscope **Description:** Tantalum thin film on a silicon substrate.



Daniel E. Bujanda, University of Texas at El Paso

Imaging: Transmission electron microscope **Description:** A sample of 316L stainless steel used in forming a

Caribbean steel drum.